

FORM PTO-1449 (Rev. 2-32)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. KIK01 P-322A	SERIAL NO. 10/737,336
 INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)		APPLICANTS	Kenichiro Kobayashi et al.
		FILING DATE	GROUP 2614- 2863

U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
XS	9 0 4 9 7 0 6	02/18/1997	Japan			X	
XS	7 1 1 0 2 1 6	04/24/1995	Japan			X	

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

(Form PTO-1449 (6-4))

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U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE IF APPROPRIATE
X5	5 3 4 3 2 8 7	08/30/1994	Wilkins			
1	4 6 2 1 0 6 3	11/04/1986	Wyatt et al.			
1	4 7 9 4 3 8 4	12/27/1988	Jackson			
X5	5 6 3 3 7 1 4	05/27/1997	Nyyssonen			

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION
						Y N
X5	DE 19 7 3 9 6 79 A1 10/1998	Germany				
	2 7 0 1 7 6 2 08/1994	France				
	DE 19 8 1 7 6 64 A1 11/1999	Germany				
	DE 19 9 0 9 2 35 A1 09/1999	Germany				
X5	DE 19 6 2 0 4 19 A1 11/1997	Germany				

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER INITIAL	
X5	U.S. Patent Application Publication 2002/0080264, publication date June 27, 2002 entitled METHOD AND APPARATUS FOR DIRECT IMAGE PICK-UP OF GRANULAR SPECK PATTERN GENERATED BY REFLECTING LIGHT OF LASER BEAM

EXAMINER	DATE CONSIDERED
<i>Ming S</i>	09/27/04

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